

Tailoring SSD Architectures to Meet Evolving PC User Requirements

Doreet Oren, Director Product Marketing SSD Avi Klein, Senior Principal Engineer SanDisk



Everywhere, Anywhere, All the Time





- SSD and the evolving usage scenarios
- Ecosystem collaboration
- Case study: The operating system & SSD
- Understanding the NAND challenge
- Directions & solutions to meet user needs



During our meeting today we will be making forward-looking statements.

Any statement that refers to expectations, projections or other characterizations of future events or circumstances is a forward-looking statement, including those relating to revenue, pricing, market share, market growth, product sales, industry trends, expenses, gross margin, future memory technology, production capacity and technology transitions and future products.

Actual results may differ materially from those expressed in these forwardlooking statements including due to the factors detailed under the caption "Risk Factors" and elsewhere in the documents we file from time-to-time with the SEC, including our annual and quarterly reports.

We undertake no obligation to update these forward-looking statements, which speak only as of the date hereof.



New SSD - as Different from an HDD as the Horseless Carriage from the Race Car

















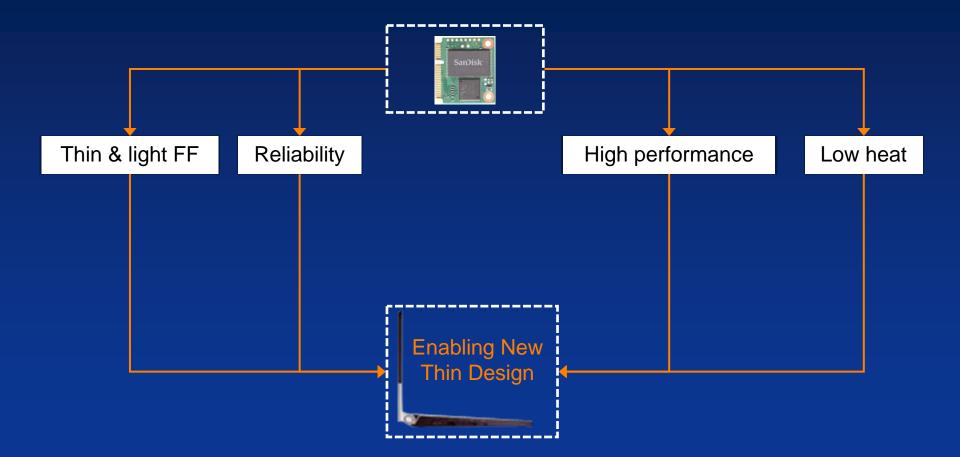
New Thin Designs – Enabled with SSD

Laptop Side-View



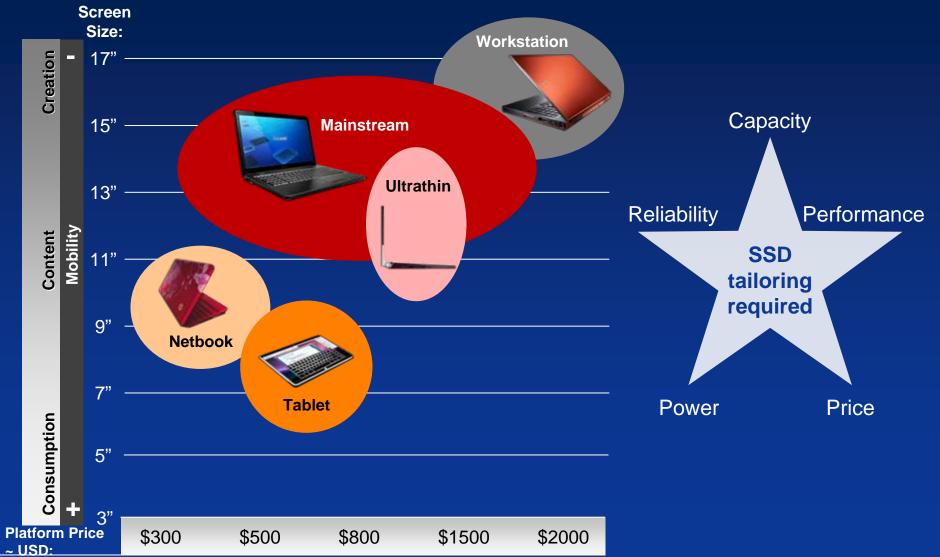


SSD Enabling - New Thin Mobile Computing Designs





Different SSDs for Different Computing Segments





Mainstream Computing Market



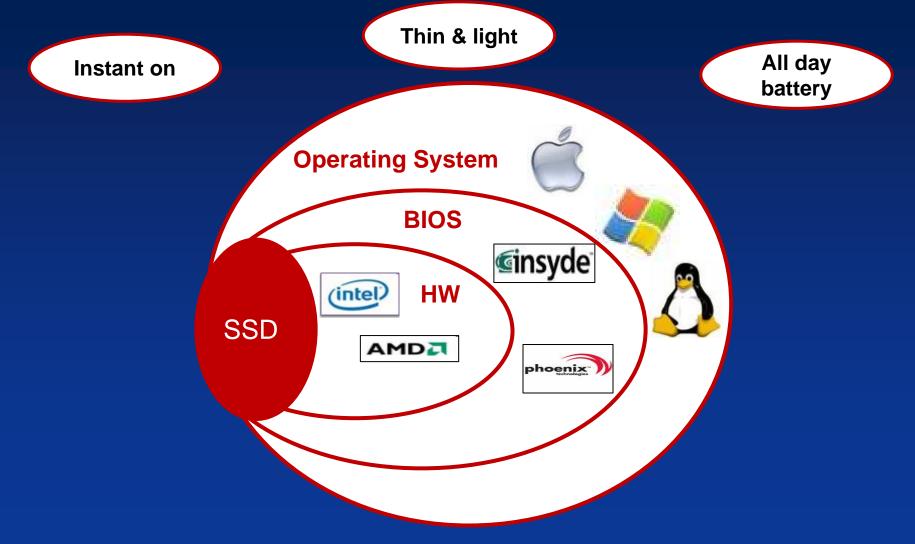
- 2014 NAND consumption mainstream PC market 13 Exabytes^{*}
- Usage: Business & Consumer Apps
- Screen:15.4" 13"
- Processor: Core2 Duo, CULV
- OS: Windows Professional, MAC OS
- Storage: 64GB 256GB
- Price: \$800-\$1000

*Gartner, Inc., Semiconductor Forecast Worldwide: Forecast Database, N. Reilly et al, 1 June 2010

Ecosystem Engaged in an Enhanced User Experience

FR

SanDisk'



Innovation & Collaboration Computex 2010



Ecosystem Engaged in an FR **Enhanced User Experience** SanDisk[,] Thin & light All day Instant on battery **Operating System BIOS Ginsyde** HW SSD phoenix



The OS Home for Many Years Access Takes Time



A New Home Offers New Challenges



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Different Architectures Different Behavior OS Storage Awareness Makes a Difference



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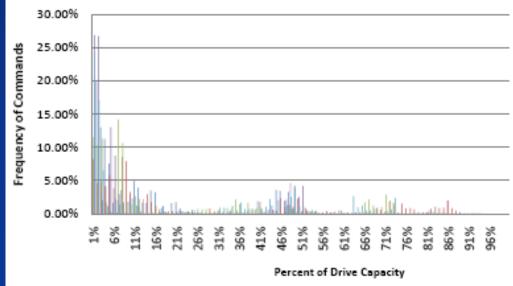
SanDisk Internal Windows 7 Study

- Purpose: Analyze and characterize:
 OS I/O interface with the storage device
- Various corporate user groups observed running Windows 7 Ultimate
- Data traces from the host to the device were captured
 - SATA analyzer individual tasks traced
 - High-level filter driver real user activity, recording realtime I/O operations



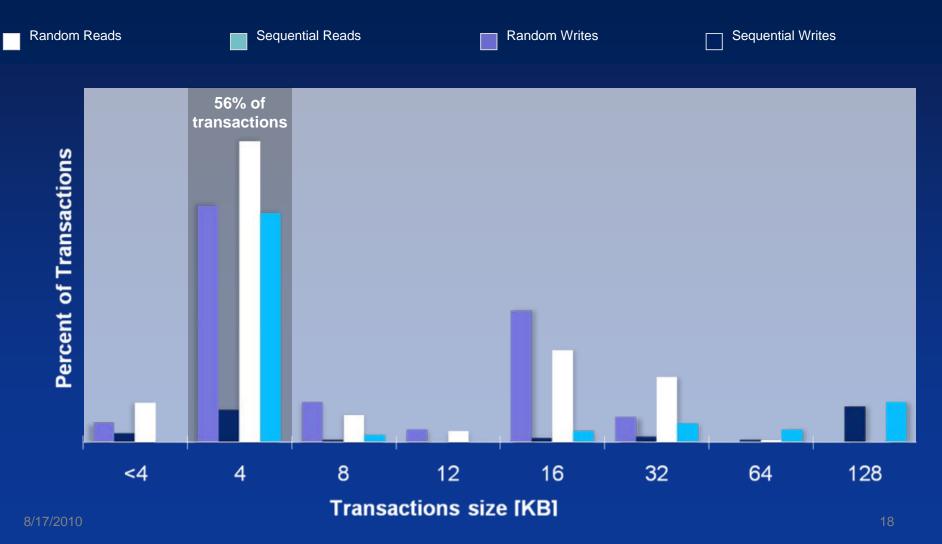
Footprint of Corporate Usage

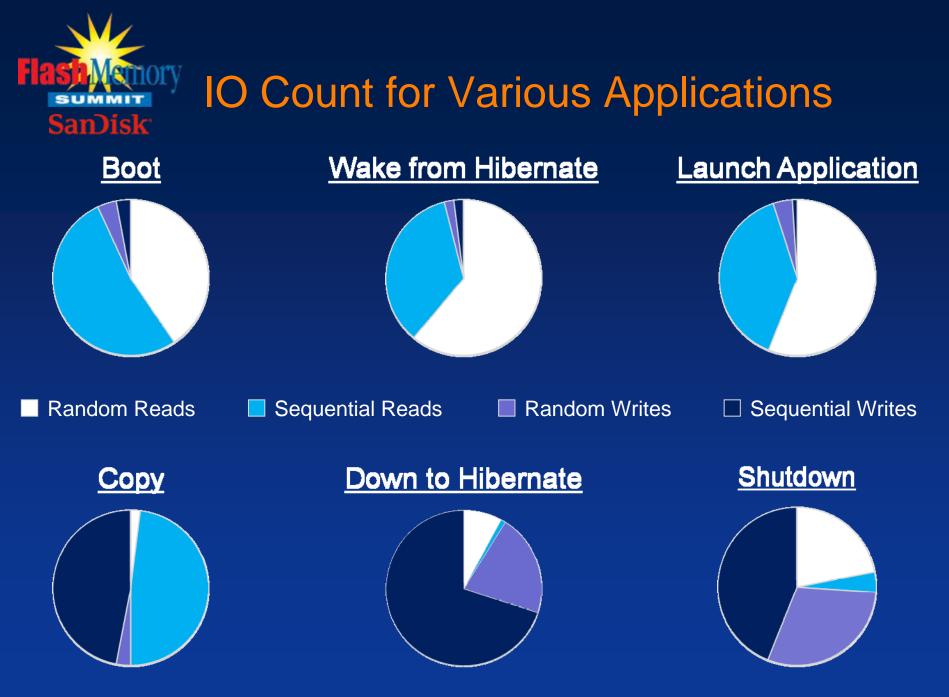
- Examination of variety of different corporate user's behavior and different disk size
- Found <u>recurrence of hot spots</u> in specific locations (not evenly distributed over the media)
- SSD designer must be take into account the flash wear-out implication





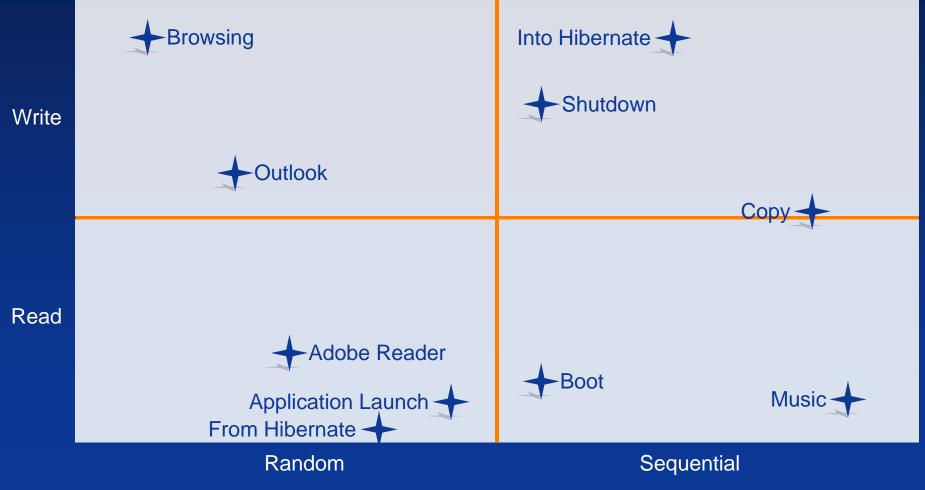
Scenario Distribution by Block Size





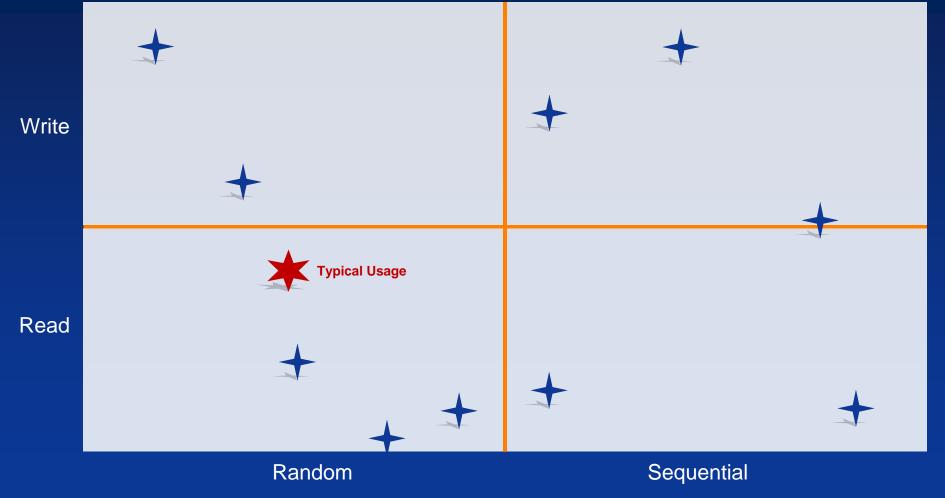


Applications – R/W, Sequential / Random Disk Activity Distribution





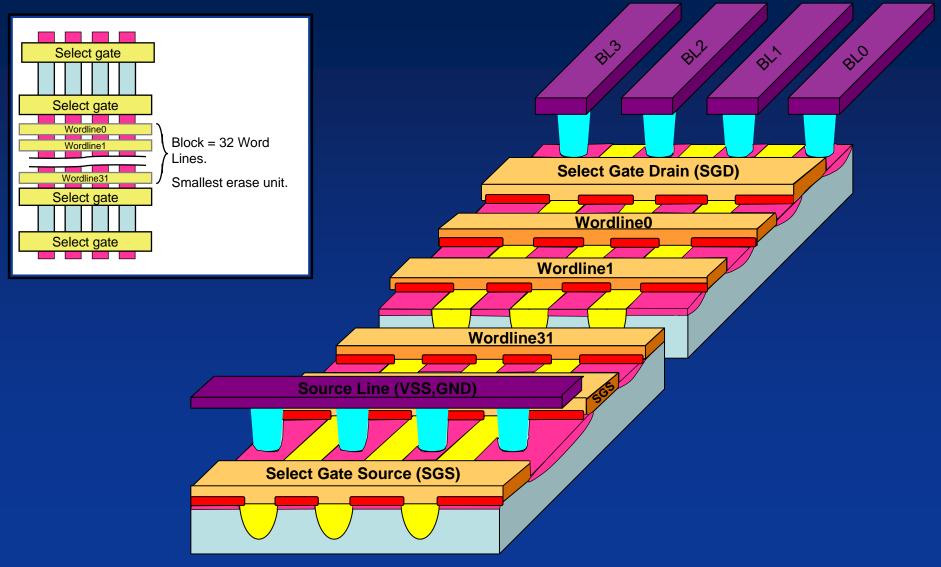
Applications – R/W, Sequential / Random Disk Activity Distribution





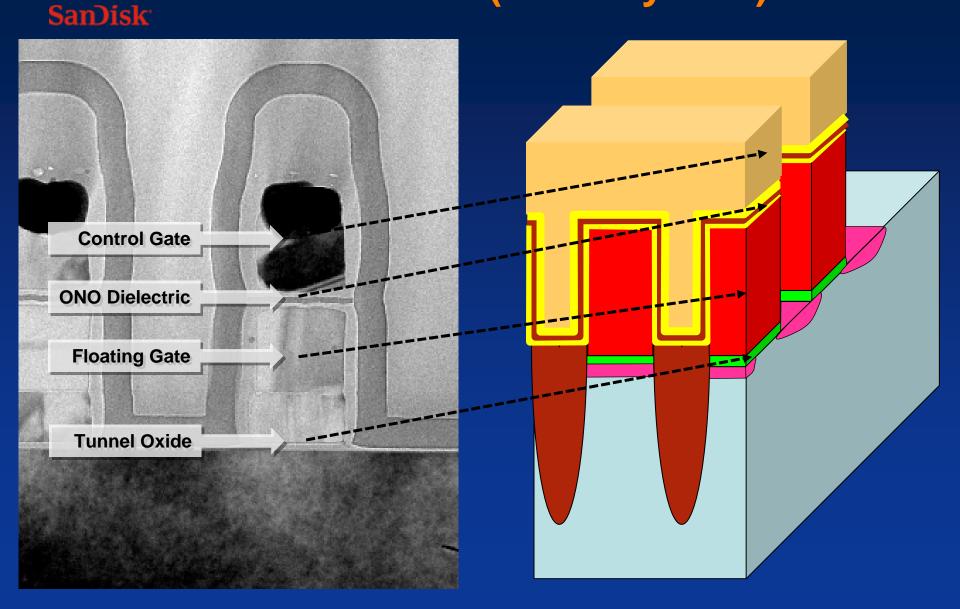


NAND Basics (Array Structure)



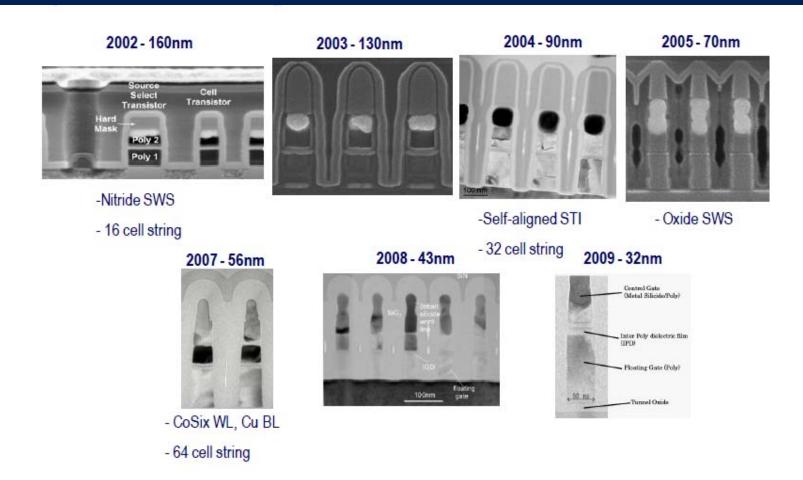
NAND Basics (Memory Cell)

F





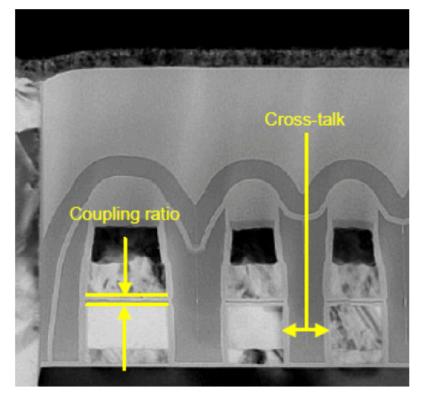
NAND Technology Evolution

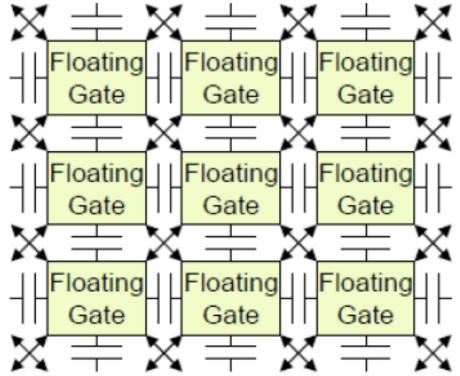


Source: Chipworks, Semiconductor Insights, Toshiba (Forward Insights Dec 2009)



NAND Scaling Challenges – Interferences

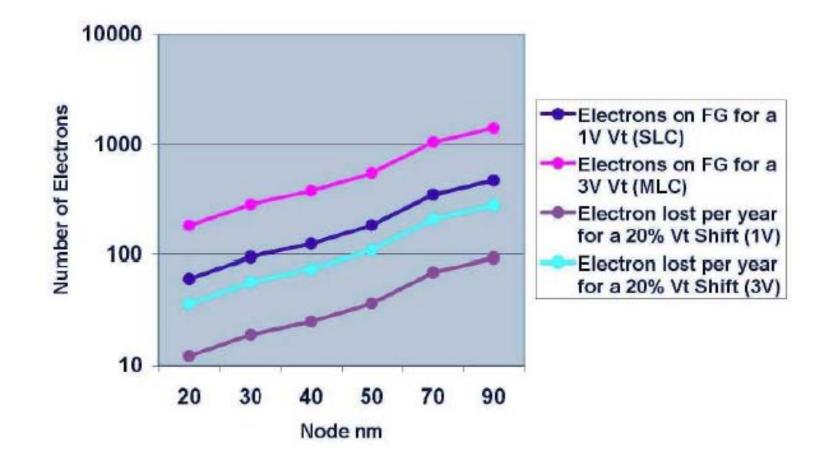




Source: Semiconductor Insights



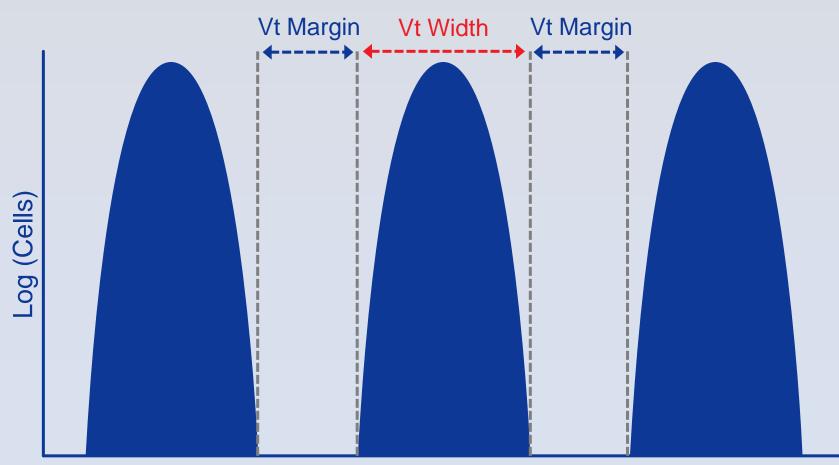
NAND Scaling Challenges – Less Electrons





Reliability Margins

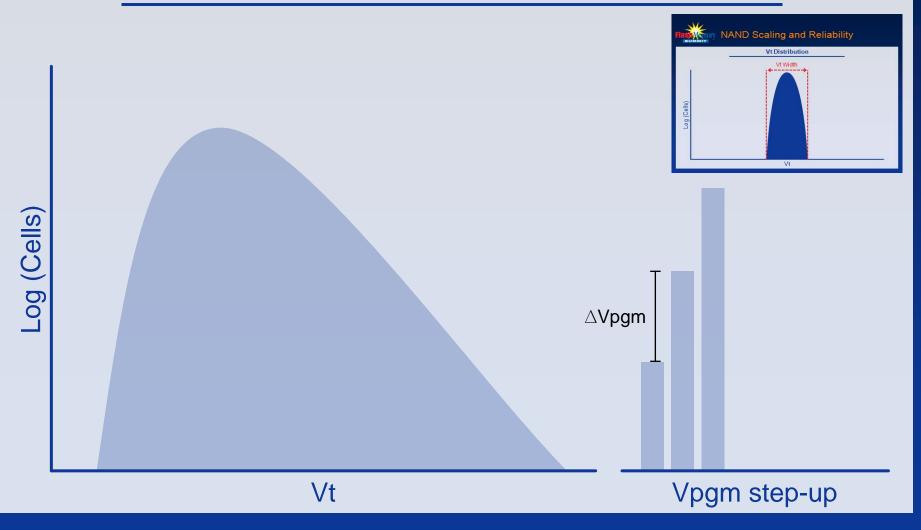
Vt Distribution





Control of Vt Distribution by Programming steps

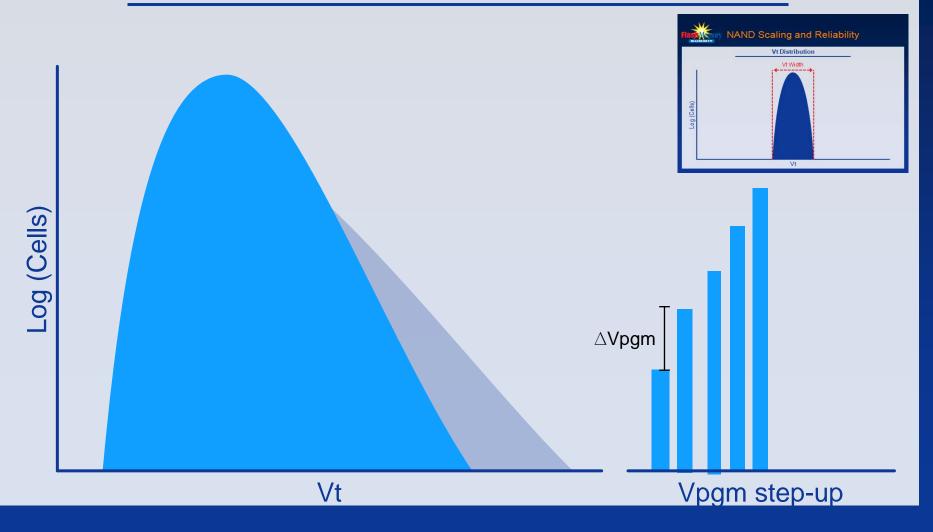
Vt Distribution for Different Vpgm Step Sizes





Control of Vt Distribution by Programming steps

Vt Distribution for Different Vpgm Step Sizes





Control of Vt Distribution by Programming Steps

Vt Distribution for Different Vpgm Step Sizes

Smaller programming voltage step size → Narrower distributions but longer programming time

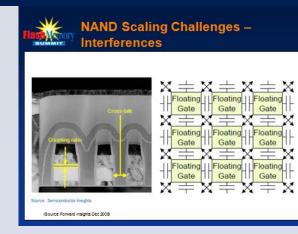
∆Vpgm

Vpgm step-up



Vt





Interferences and noise cause the Vt Distribution to shift and widen



The Effect of Cycling + Data Retention

VT Shift after Data Retention

Low cycling counts

Cycling and data retention result in shift and widening of the Vt distribution

Higher Cycling counts -



The Effect of Scale Down (Technology Shrink)

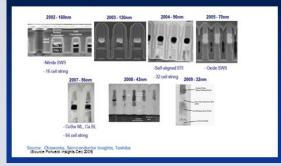
Vt Distribution Comparison

Vt

NAND Technology Evolution

Flash

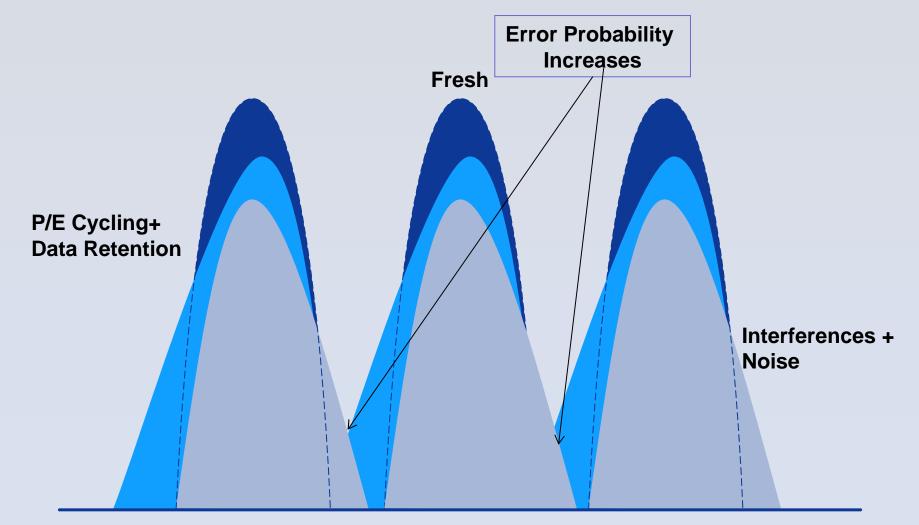
Current Technology Future (Shrink) Technology



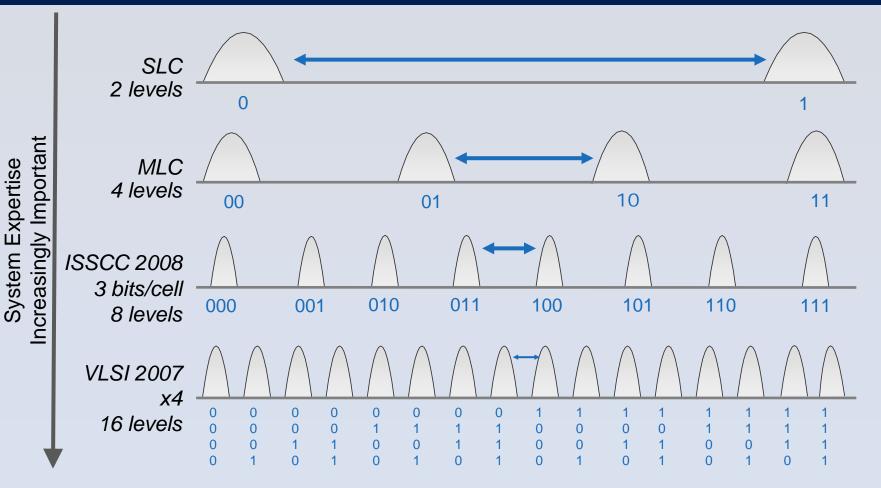
Vt distributions wider because of adjacent cell interference and other small geometry effects



Putting It All Together : The Cumulative Effect







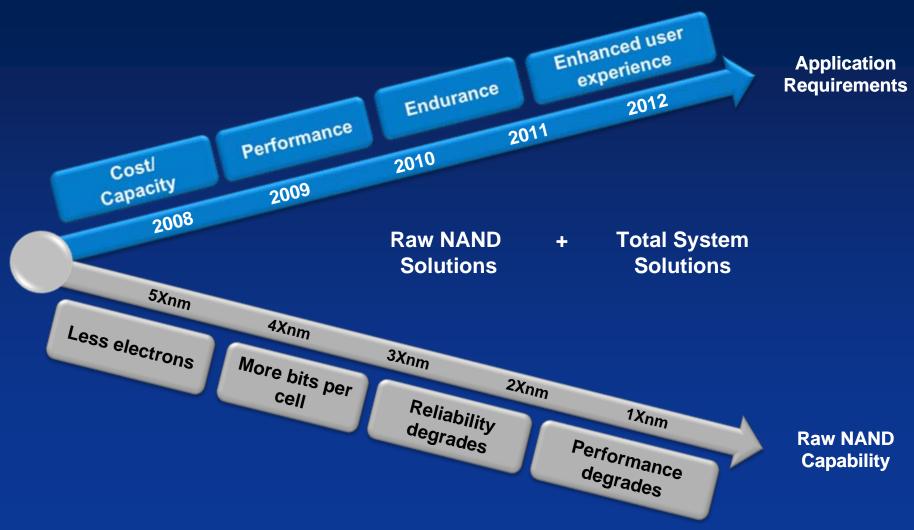
• Distance between adjacent voltage levels is significantly shorter

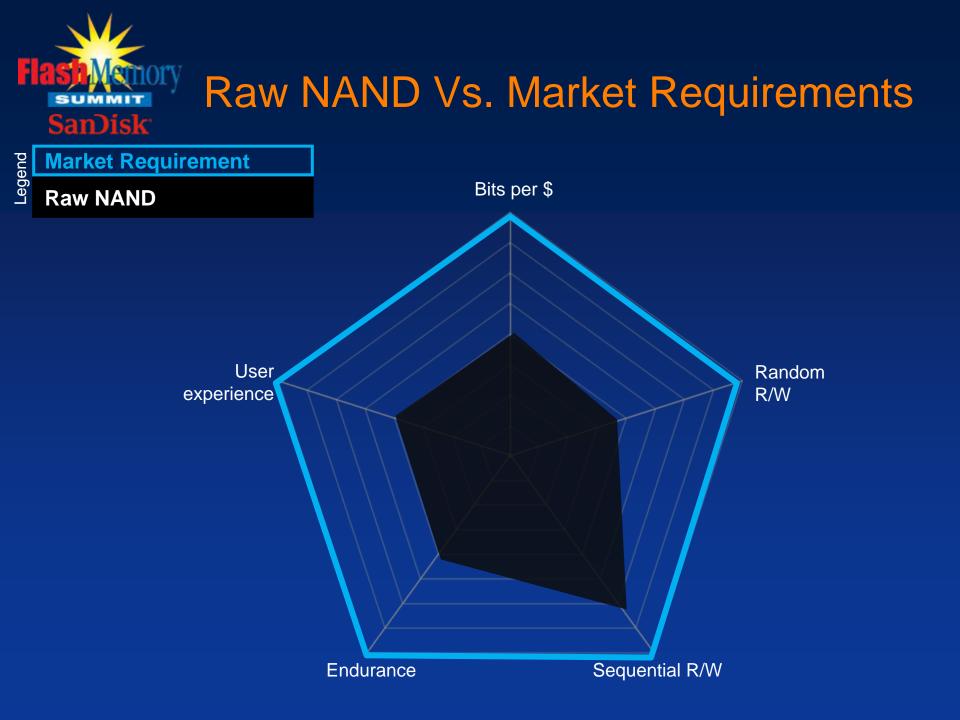
SanDisk'

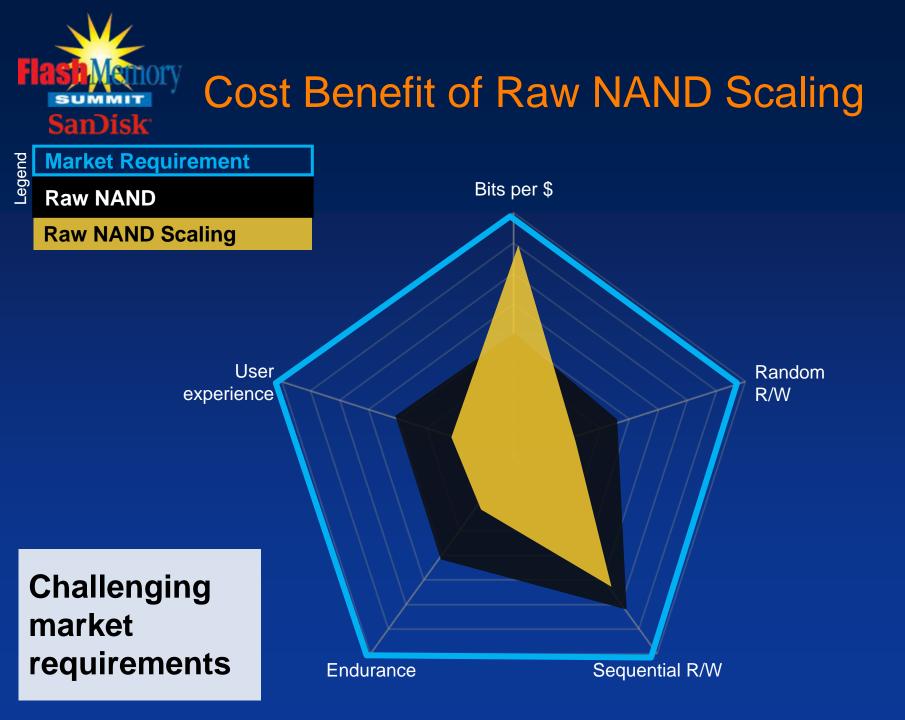
• Error probability increases (overlap) due to Vt distribution shift and widening.

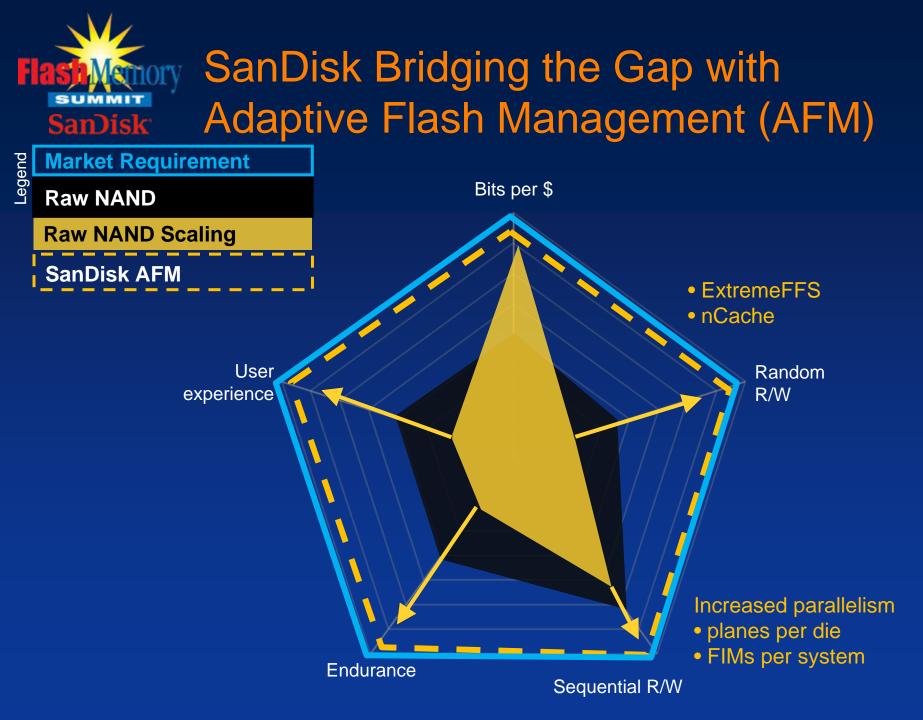


Bridging the Gap











Thank You!